

**Search Notes**

Application/Control No.

10/053,329

Examiner

Michael J. Hayes

Applicant(s)/Patent under  
Reexamination

BAUDINO ET AL.

Art Unit

3763

**SEARCHED**

Class	Subclass	Date	Examiner
604	890.1 891.1 892.1 93.01 65 66		
	67 164.01		
	164.08		
	131		
	288.01		
	288.02		
	288.03		
	288.04		
128	dig. 12		
		1/19/2005	MJH

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner